

RoHS Compliant Product
A suffix of "-C" specifies halogen & lead-free

DESCRIPTION

SJP130SN06-C uses shielded gate trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

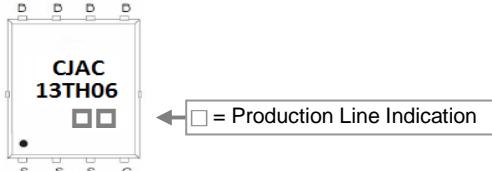
FEATURES

- High density cell design for ultra low $R_{DS(ON)}$
- High Power and current handing capability
- Load switch
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation
- Lead free product is acquired

APPLICATIONS

- SMPS and general purpose applications
- Hard switched and high frequency circuits
- Uninterruptible Power Supply
- Power management

MARKING



PACKAGE INFORMATION

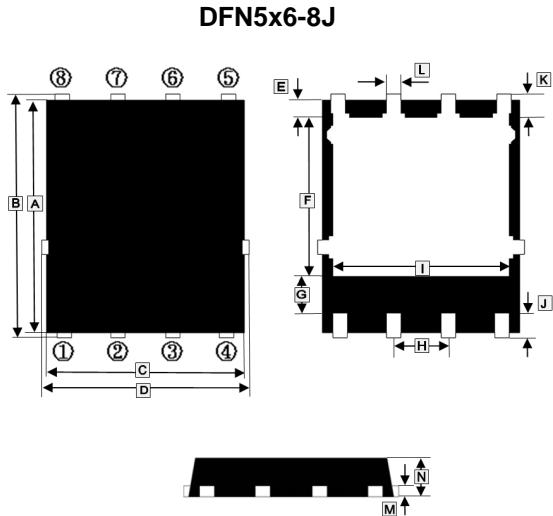
| Package | MPQ | Leader Size |
|-----------|-----|-------------|
| DFN5x6-8J | 5K | 13 inch |

ORDER INFORMATION

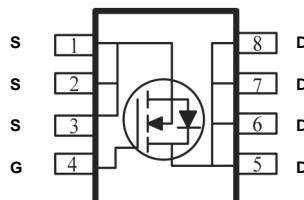
| Part Number | Type |
|--------------|---------------------------------|
| SJP130SN06-C | Lead (Pb)-free and Halogen-free |

ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise specified)

| Parameter | Symbol | Rating | Unit |
|--|-----------------|--------------|------|
| Drain-Source Voltage | V_{DS} | 60 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current | I_D | 130 | A |
| Pulsed Drain Current ¹ | I_{DM} | 390 | A |
| Power Dissipation | P_D | 140 | W |
| Avalanche Energy ³ | E_{AS} | 80 | mJ |
| Thermal Resistance from Junction to Ambient ² | $R_{\theta JA}$ | 62 | °C/W |
| Thermal Resistance from Junction to Case | $R_{\theta JC}$ | 0.89 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | 150, -55~150 | °C |



| REF. | Millimeter | | REF. | Millimeter | |
|------|------------|-------|------|------------|------|
| | Min. | Max. | | Min. | Max. |
| A | 5.65 | 5.85 | H | 1.27 TYP. | |
| B | 5.90 | 6.15 | I | 3.85 | 4.15 |
| C | 4.80 | 5.00 | J | 0.51 | 0.86 |
| D | 5.02 TYP. | | K | 0.55 | 0.85 |
| E | 0.38 | 0.576 | L | 0.33 | 0.50 |
| F | 3.25 | 3.58 | M | 0.254 REF. | |
| G | 1.10 | 1.39 | N | 0.90 | 1.17 |



ELECTRICAL CHARACTERISTICS ($T_A=25^\circ C$ unless otherwise specified)

| Parameter | Symbol | Min. | Typ. | Max. | Unit | Test Condition |
|--|---------------|------|------|-----------|-----------|----------------------------------|
| Drain-Source Breakdown Voltage | $V_{(BR)DSS}$ | 60 | - | - | V | $V_{GS}=0V, I_D=250\mu A$ |
| Zero Gate Voltage Drain Current | I_{DSS} | - | - | 1 | μA | $V_{DS}=60V, V_{GS}=0V$ |
| Gate-Body Leakage Current | I_{GSS} | - | - | ± 100 | nA | $V_{DS}=0V, V_{GS}= \pm 20V$ |
| Gate-Threshold Voltage ¹ | $V_{GS(th)}$ | 1 | - | 2.5 | V | $V_{DS}=V_{GS}, I_D=250\mu A$ |
| Static Drain-Source On-Resistance ¹ | $R_{DS(ON)}$ | - | 2.2 | 3 | $m\Omega$ | $V_{GS}=10V, I_D=12A$ |
| | | - | 3 | 4.5 | | $V_{GS}=4.5V, I_D=12A$ |
| Gate Resistance | R_g | - | 2.5 | - | Ω | $V_{DS}=0V, V_{GS}=15mV, f=1MHz$ |
| Total Gate Charge | Q_g | - | 63.7 | - | nC | $V_{DS}=30V$ |
| Gate-Source Charge | Q_{gs} | - | 10.3 | - | | $V_{GS}=10V$ |
| Gate-Drain Charge | Q_{gd} | - | 11.4 | - | | $I_D=25A$ |
| Turn-on Delay Time | $T_{d(on)}$ | - | 21.8 | - | nS | $V_{DS}=30V$ |
| Rise Time | T_r | - | 6.3 | - | | $V_{GS}=10V$ |
| Turn-off Delay Time | $T_{d(off)}$ | - | 78.5 | - | | $R_G=2\Omega$ |
| Fall Time | T_f | - | 27.1 | - | | $I_D=25A$ |
| Input Capacitance | C_{iss} | - | 5298 | - | pF | $V_{DS}=25V$ |
| Output Capacitance | C_{oss} | - | 1635 | - | | $V_{GS}=0V$ |
| Reverse Transfer Capacitance | C_{rss} | - | 74.8 | - | | $f=100kHz$ |
| Drain-Source Diode Characteristics | | | | | | |
| Diode Forward Voltage ¹ | V_{SD} | - | - | 1.3 | V | $V_{GS}=0V, I_s=20A$ |

Notes:

1. Pulse test: Pulse width $\leq 300\mu s$, duty cycle $\leq 0.5\%$.
2. The value of $R_{θJA}$ is measured with the device mounted on 1 in 2 FR-4 board with 1.5oz.Copper, in a still air environment with $T_A=25^\circ C$.
3. E_{AS} test condition $V_{DD}=50V$, $R_G=25\Omega$, $L=0.3mH$, starting $T_J=25^\circ C$.

CHARACTERISTICS CURVE

